Dewetting of an ultrathin solid film on a lattice-matched or amorphous substrate

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An evolution partial differential equation for the surface of a nonwetting single-crystal film in an attractive substrate potential is derived and used to study the dynamics of a pinhole for the varying initial depth of a pinhole and the strengths of the potential and the surface energy anisotropy. The results of the simulations demonstrate how the corresponding parameters may lead to complete or partial dewetting of the film. Anisotropy of the surface energy, through faceting of the pinhole walls, is found to most drastically affect the time to film rupture. In particular, the simulations support the conjecture that the strong anisotropy is capable of a complete suppression of dewetting even when the attractive substrate potential is strong.

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I. INTRODUCTION

Under typical operation conditions, the thin solid film devices heat up to temperatures as high as 1000 °C, without melting. A high temperature activates the mass transport by surface diffusion. Thus, the film morphology changes, which often results in harmful impacts on device structural integrity. On the other hand, it is well known that thin *liquid* films (where the mass transport is by bulk hydrodynamic flows) are subject to dewetting caused by the long-range filmsubstrate interactions (which are also called wetting interactions). Dewetting results in film rupture and the agglomeration of liquid in droplets. The wetting interactions contribute noticeably to the liquid film dynamics when the thickness of a film is of the order of a few microns. Since this characteristic length scale is of the order of 10 nm for solid films, 1,2 and due to a high temperature activation barrier for surface diffusion, the dewetting of solid thin films is not as common. The structural integrity of a film must be maintained for a device to function properly. Thus, it is important to understand the process of dewetting and find a means to control it.

One material system which exhibits solid film dewetting is the silicon-on-insulator. It comprises the ultrathin silicon film deposited on the amorphous SiO_2 substrate. The main feature of such a system is the absence of stress at the film-substrate interface. The experiments 1,2 with the sub-10-nm Si films at $800-900\,^{\circ}\mathrm{C}$ demonstrate that dewetting starts at pinholes in the Si planar surface. The pinholes may exist prior to the annealing or they form shortly after the temperature is raised. The critical depth of the pinhole that is necessary to initiate dewetting is presently unknown (apparently, not all pinholes dewet), nor is known the kinetics of the pinhole deepening and the pinhole shape.

Due to anisotropy of the film surface energy, it is natural to expect that the dynamics of a pinhole and the rupture process are qualitatively different from the dewetting and the rupture of a liquid surface having an isotropic surface tension. In particular, since the crystal surface tends to facet when its orientation falls in the unstable range, it is not *a priori* clear that dewetting, when it is initiated by substrate attraction of the initially slightly deformed free surface, not exhibiting unstable orientations, will proceed to rupture. A somewhat similar situation occurs in strongly anisotropic

grain boundary grooving. Interestingly, it was demonstrated³ that such a groove can be smooth and have the same shape as the isotropic groove, but the growth rate is reduced by a factor that depends on the degree of anisotropy.

This paper attempts to clarify the isssue by studying the dynamics of the pinhole with varying initial depth and for different strengths of the potential and the surface energy anisotropy.

There have been several theoretical models published on the dynamics of thin solid films, where wetting interactions are accounted for;^{4–7} these continuum models are primarily designed for the description of a self-assembly process in the course of the epitaxial crystal growth. In contrast to this paper, these models assume that the film wets the substrate, meaning that $\partial \mu_w / \partial h|_{h=const.} > 0$, where μ_w is the wetting chemical potential and h is the film height. Also, dewetting of a solid monolayer was recently studied susing a solid-on-solid model and the kinetic Monte Carlo simulations. Dewetting of a monolayer proceeds through the nucleation and growth of holes in the film, which are caused by the discreteness of the underlying crystalline lattice and the substrate roughness. This is not the case for thicker films considered here.

For solid films there is currently several choices of the wetting model, including the two-layer wetting model^{4–6,9} and the van der Waals potential.^{7,10} In this study, the former model is used due to its generality. It has been demonstrated in Refs. 11 and 12 that the two-layer wetting model is consistent with *ab initio* calculations, but presently there is no experimental studies in which the wetting interaction potential has been measured.

The continuum model of this paper is based on the wellestablished physicomathematical framework which originated from the works of Mullins^{13,14} and Herring^{15,16} half a century ago. Mullins derived the first partial differential equations for the description of the surface morphology changes by surface diffusion (capillarity), evaporationrecondensation, and bulk diffusion. Herring was first to systematically study the dependence of the equilibrium crystal shape¹⁷ on the surface energy anisotropy. The experiments¹⁸ demonstrate that the equilibrium shape can be partially or completely faceted, with the atomically sharp edges and corners and straight facets emerging when the anisotropy is strong, or with the smooth junctions and curved facets emerging when the anisotropy is weak. Other authors studied the dynamics of the crystal surface evolution with the strongly anisotropic surface energy and ways of regularizing the mathematical ill-posedness of the evolution problem (and the removal of the associated fine-scale instability). 3,19-28 The preferred method of regularization is the addition of a small curvature-dependent term to the surface energy. 29-32,19,20 This term penalizes the sharp corners and makes them rounded on a small length scale. 16

II. PROBLEM STATEMENT

A two-dimensional film with a free one-dimensional surface z=h(x,t) is assumed, where h is the height of the film surface above the substrate. The surface evolves by surface diffusion.

Under these assumptions, the governing equation for h(x,t) has the form

$$h_t = \frac{\Omega D \nu}{kT} \frac{\partial}{\partial x} \left((1 + h_x^2)^{-1/2} \frac{\partial \mu}{\partial x} \right), \tag{1}$$

where Ω is the atomic volume, D the adatom diffusivity, ν the adatom surface density, k the Boltzmann constant, T the absolute temperature, and $\mu = \mu_{\kappa} + \mu_{w}$ the surface chemical potential. Here, μ_{κ} is the regular contribution due to the surface mean curvature κ . ^{13,33} Also, $(1+h_{x}^{2})^{-1/2} = \cos\theta$, where θ is the angle that the unit surface normal makes with the [01] crystalline direction, along which is the z axis. (The x axis is along the [10] direction.) Thus, θ measures the orientation of the surface with respect to the underlying crystal structure. Note that here and below, the subscripts x, t, and θ denote differentiation.

The wetting chemical potential

$$\mu_w = \Omega(1 + h_x^2)^{-1/2} \frac{\partial \gamma(h)}{\partial h},\tag{2}$$

where, in the two-layer wetting model,

$$\gamma(h) = \gamma^{(f)}(\theta) + [\gamma_s - \gamma^{(f)}(\theta)] \exp(-h/\ell)$$
 (3)

is the thickness-dependent surface energy density of the film-substrate interface. Here, $\gamma_s = const$ is the surface energy density of the substrate in the absence of the film, and ℓ is the characteristic wetting length. Thus, $\gamma(h) \to \gamma^{(f)}$ as $h \to \infty$, and $\gamma(h) \to \gamma_s$ as $h \to 0$. $\gamma^{(f)}(\theta)$ is the energy density of the film surface, assumed strongly anisotropic. The strong anisotropy possibly leads to faceting. (Below, when a reference to the surface energy density is made, the word "density" is omitted for brevity).

 $\gamma^{(f)}(\theta)$ is taken in the form

$$\gamma^{(f)}(\theta) = \gamma_0 (1 + \epsilon_\gamma \cos 4\theta) + \frac{\delta}{2} \kappa^2, \tag{4}$$

where γ_0 is the mean value of the film surface energy in the absence of the substrate potential (equivalently, the surface energy of a very thick film), ϵ_{γ} determines the degree of anisotropy, and δ is the small non-negative regularization parameter having units of energy. The δ term in Eq. (4)

makes the evolution Eq. (1) mathematically well-posed for strong anisotropy. $^{29-32,19,20}$ (The anisotropy is weak when $0 < \epsilon_{\gamma} < 1/15$ and strong when $\epsilon_{\gamma} \ge 1/15$. $\delta = 0$ in the former case. In the latter case, the polar plot of $\gamma^{(f)}(\theta)$ has cusps at the orientations that are missing from the equilibrium Wulff shape and the surface stiffness $\gamma^{(f)} + \gamma^{(f)}_{\theta\theta}$ is negative at these orientations. 15,16 Thus, the evolution equation is ill-posed unless regularized. 29,30) The form (4) assumes that the surface energy is maximum in the [01] direction.

The curvature contribution to the chemical potential has the form

$$\mu_{\kappa} = \Omega(\gamma^{(f)} + \gamma_{\theta\theta}^{(f)} - H)\kappa, \tag{5}$$

where $\gamma^{(f)}(\theta)$ has the form (4) with the mean value γ_0 replaced by the effective value $\bar{\gamma}_0$ that reflects the presence of the substrate:

$$\overline{\gamma}_0 = \frac{1}{h_0} \int_0^{h_0} \left[\gamma_0 + (\gamma_s - \gamma_0) \exp\left(-\frac{z}{\ell}\right) \right] dz. \tag{6}$$

Here, h_0 =const is the unperturbed film height. The H term in Eq. (5) is nonzero only for strong anisotropy, and it ensures the continuity of the chemical potential across corners on the faceted crystal shape. The form of this term is²⁰

$$H = \kappa \left(\frac{1}{2} + \frac{d^2}{d\theta^2}\right) \left(\frac{\partial \gamma^{(f)}}{\partial \kappa}\right) + \frac{\partial^2 \gamma^{(f)}}{\partial \kappa^2} \left(\frac{d\kappa}{d\theta}\right)^2. \tag{7}$$

Finally, $\kappa = -h_{xx}(1 + h_x^2)^{-3/2}$.

To nondimensionalize the problem, h_0 is chosen as the length scale and h_0^2/D as the time scale. Also, let $r = \ell/h_0$. Substitution of μ_{κ} and μ_{w} in Eq. (1) gives

$$h_t = B \frac{\partial}{\partial r} (q P_{\kappa}^{(1)} - \Delta P_{\kappa}^{(2)} + P_{w}^{(1)} - \Delta P_{w}^{(2)}), \tag{8}$$

where h, x, and t are nondimensional, $B = \Omega^2 \nu \gamma_0 / kT h_0^2$, $\Delta = \delta / \gamma_0 h_0^2$ is the nondimensional regularization parameter, and q, $P_\kappa^{(1,2)}$, and $P_\omega^{(1,2)}$ are the following quantities.

$$q = 1 + r \left(\frac{\gamma_s}{\gamma_0} - 1\right) [1 - \exp(-1/r)] > 0,$$
 (9)

$$P_{\kappa}^{(1)} = \frac{\partial}{\partial x} [(1 - 15\epsilon_{\gamma}\cos 4\theta)\kappa]\cos \theta, \tag{10}$$

$$P_{\kappa}^{(2)} = \frac{\partial}{\partial x} \left[\frac{\kappa^3}{2} + \frac{\partial}{\partial x} \left(\frac{\partial \kappa}{\partial x} \cos \theta \right) \cos \theta \right] \cos \theta, \quad (11)$$

$$P_w^{(1)} = \frac{\exp(-h/r)h_x}{r(1+h_x^2)^4} \left[r^{-1}a_1(1+h_x^6) + 3r^{-1}a_5h_x^2(1+h_x^2) + a_2 + 2a_4h_x^2 + a_1h_x^4\right],\tag{12}$$

$$P_{w}^{(2)} = \frac{\exp(-h/r)}{2r(1+h_{x}^{2})^{5}} \{r^{-1}h_{xx}^{2}h_{x}(1+h_{x}^{2}) + h_{xx}[7h_{xx}^{2}h_{x} - 2h_{xxx}(1+h_{x}^{2})]\}.$$

$$(13)$$

Note that $P_w^{(1)}$ and $P_w^{(2)}$ are proportional to $\exp(-h/r)$. In Eqs.

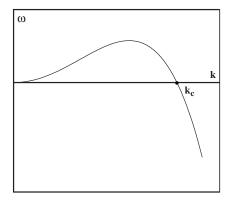


FIG. 1. Sketch of the linear growth rate $\omega(k)$. Perturbations with wave numbers $0 < k < k_c$ are unstable and may grow nonlinearly until the film ruptures.

(12) and (13), $a_1 = \Gamma - 1 - \epsilon_{\gamma}$, $a_2 = \Gamma - 1 - 17\epsilon_{\gamma}$, $a_4 = \Gamma - 1 + 11\epsilon_{\gamma}$, and $a_5 = \Gamma - 1 + 5\epsilon_{\gamma}/3$. Thus, Eq. (8) contains five parameters, B, r, ϵ_{γ} , Δ , and $\Gamma = \gamma_s/\gamma_0$ (where $\Delta = 0$ when $0 < \epsilon_{\gamma} < 1/15$).

From Eqs. (2)–(4), it is easy to see that the requirement of zero wetting between the film and the substrate, $\partial \mu_w / \partial h|_{h=h_0} < 0$, is equivalent to requiring negative a_1 , i.e., $\Gamma < 1 + \epsilon_y$. Thus, in what follows, $a_1 < 0$.

Equation (8) can be written also in the widely used small-slope approximation (SSA), where $|\partial/\partial x| = \epsilon \ll 1$:

$$h_t = B \frac{\partial}{\partial x} (q P_{\kappa}^{(1)} - \Delta P_{\kappa}^{(2)} + P_{w}^{(1)} - \Delta P_{w}^{(2)}), \tag{14}$$

$$P_{\kappa}^{(1)} = \Lambda_1 h_{xxx} + \Lambda_2 h_{xx}^2 h_x + \Lambda_3 h_{xxx} h_x^2, \tag{15}$$

$$P_{\kappa}^{(2)} = -h_{xxxxx},\tag{16}$$

$$P_w^{(1)} = \frac{\exp(-h/r)}{r} [a_2 h_{xx} h_x (1 - 5h_x^2) + r^{-1} h_x (a_1 + (2a_3 - 3a_1)h_x^2 + a_6 h_x^4)]; \tag{17}$$

$$P_w^{(2)} = \frac{\exp(-h/r)}{r} h_{xx} \left[\frac{1}{2} r^{-1} h_{xx} h_x - h_{xxx} \right].$$
 (18)

In Eq. (15), $\Lambda_1 = 15\epsilon_{\gamma} - 1$, $\Lambda_2 = 3 - 285\epsilon_{\gamma}$, and $\Lambda_3 = 2 - 150\epsilon_{\gamma}$. In Eq. (17), $a_3 = \Gamma - 1 + 3\epsilon_{\gamma}$ and $a_6 = \Gamma - 1 - 25\epsilon_{\gamma}$. Also note that the non-negative Λ_1 signals that the surface energy anisotropy is strong. Equation (14) has the same form as the evolution equation (26) of Ref. 5.

In the simulations reported below, the following values of the physical parameters are used: $D=1.5\times10^{-6}~\rm cm^2/s,~\Omega=2\times10^{-23}~\rm cm^3,~\gamma_0=10^3~\rm erg/cm^2,~\gamma_s=5\times10^2~\rm erg/cm^2,~\nu=10^{15}~\rm cm^{-2},~kT=1.12\times10^{-13}~\rm erg,~h_0=10^{-6}~\rm cm,~and~\delta=5\times10^{-12}~\rm erg.$ These values translate into $B=3.57\times10^{-3},~\Gamma=0.5,~\rm and~\Delta=5\times10^{-3}~\rm (or~zero).$ Values of the parameters ϵ_γ and r will be chosen later.

The method of lines is adopted for the computation. Equations (8) and (14) are discretized by finite differences on a spatially uniform staggered grid in x. In Eq. (8), the terms $P_{\kappa}^{(1,2)}$ are discretized in the nested fashion.³⁴ This, in particu-

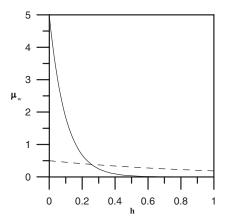


FIG. 2. The reduced nondimensional wetting chemical potential $\mu_w = -(1/r)(\Gamma - 1)\exp(-h/r)$. This formula is obtained when $\gamma_f(\theta)$ is taken isotropic and h_x is taken zero in Eq. (2). $\Gamma = 0.5$. Solid line, r = 0.1; dashed line, r = 1.

lar, requires the explicit computation of only the first- and second-order partial derivatives h_x and h_{xx} . Thus, the numerical stiffness associated with the higher order derivatives becomes less pronounced, which manifests in the significant speed-up of the computation (in the cases of the large surface slope and faceting, the speed-up factor can be as large as 300). The results provided by this and by the standard scheme agree in all cases where such a comparison was made. The integration in time of the resulting coupled system of the ordinary differential equations is done using the implicit Runge–Kutta method.

The initial condition in all runs is the surface

$$h(x,0) = 1 + \alpha \cos k_{max} x, \tag{19}$$

where α is the nondimensional perturbation amplitude (assumed not necessarily small, since the initial pinhole may extend deep into the film), and k_{max} is the wave number for which the linear growth rate of the instability is the maximum. This wave number (or the corresponding wavelength λ_{max}) is usually referred to as "the most dangerous mode." In

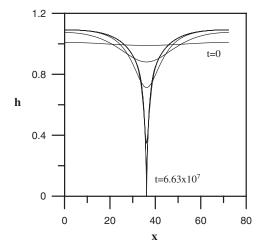


FIG. 3. Surface shapes for r=0.1 and weak anisotropy (ϵ_{γ} =1/18).

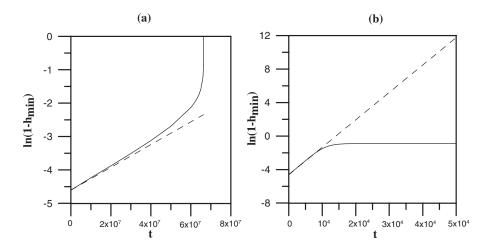


FIG. 4. (a) Growth rate data for Fig. 3. The slope of the solid line is equal to the growth rate of the instability. For comparison, the dashed line is $\ln \alpha + \omega_{max} t$, where ω_{max} is the linear growth rate. (b) Same as (a), but for Fig. 5.

Eq. (19), $0 \le x \le \lambda_{max}$ (i.e., one wavelength). The boundary conditions at x=0, λ_{max} are periodic.

Equation (8) was used in all computations. Convergence was checked on finer grids. For small surface slopes, the results provided by Eqs. (8) and (14) are identical.

III. RESULTS

The cases of weak and strong anisotropy are addressed separately.

A. Zero or weak anisotropy

Linearization of Eq. (14) about the equilibrium solution h=1 gives

$$\xi_t = B(q\Lambda_1\xi_{xxxx} + \exp(-1/r)r^{-2}a_1\xi_{xx}), \quad \Lambda_1 < 0, \quad (20)$$

where $\xi(x,t) = \exp(\omega t + ikx)$ is the perturbation of the equilibrium solution, ω is the growth rate, and k is the wave number. Thus, for the growth rate, one obtains

$$\omega(k) = B(q\Lambda_1 k^4 - W_0 k^2), \tag{21}$$

where the notation is introduced $W_0 = \exp(-1/r)r^{-2}a_1$. Obviously, $W_0 < 0$ for $a_1 < 0$. It follows from Eq. (21) that the

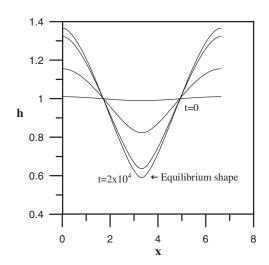


FIG. 5. Surface shapes for r=1 and weak anisotropy ($\epsilon_{\gamma} = 1/18$).

equilibrium surface is unstable $[\omega(k)>0]$ to perturbations with the wave numbers $0 < k < k_c$ [where $k_c = (W_0/Bq\Lambda_1)^{1/2}$], $\omega(0) = \omega(k_c) = 0$ and, in the interval $0 \le k \le k_c$, $\omega(k)$ has the maximum value $\omega_{max} = -W_0^2/4Bq\Lambda_1$ at $k_{max} = k_c/\sqrt{2}$. For $k \ge k_c$, the equilibrium surface is stable. Figure 1 shows the sketch of $\omega(k)$.

Simulations are performed for ϵ_{γ} =0 and 1/18, and r=0.1 and 1. The graphs of the nondimensionalized, reduced two-layer wetting chemical potential μ_w are shown in Fig. 2. For r=0.1, there is no substrate influence at the length scales larger than the unperturbed film thickness; for r=1, the substrate-film interaction matters at all length scales less than ten times the unperturbed film thickness. For r=1, the reduced potential is less strong, but more uniform across the film. Note that all figures in the paper show nondimensional quantities.

When the anisotropy is zero, the film dewets for both strengths of the wetting potential, as expected (other values of r, such as r=0.01 and r=10, have also been tried). Thus, for the remainder of the paper, the focus is on the realistic case of nonzero anisotropy, where a nontrivial evolution emerges.

Figure 3 shows the evolution of the surface shape for ϵ_{γ} = 1/18 and r=0.1. This was obtained using Eq. (8) (where

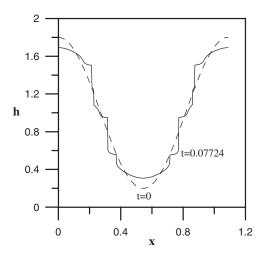
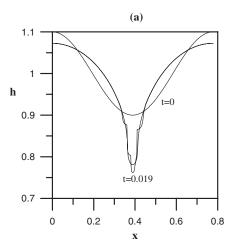


FIG. 6. Transient faceting of the surface for strong anisotropy. $\epsilon_{\gamma}=1/12$, r=0.1, and $\alpha=0.8$.



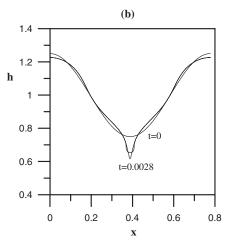


FIG. 7. Transient surface shapes for ϵ_{γ} =1/12 and r=1. (a) α =0.1. (b) α =0.25.

 Δ =0), with the initial amplitude α =0.01 in Eq. (19). The shapes are smooth. Recalling the scaling, one can see that the 10 nm film completely dewets in approximately 45 s at 800 K. This is consistent with the order of magnitude time scale in the experiments. Figure 4(a) shows $\ln(1-h_{min})$ vs time, where h_{min} is the height of the surface at the tip of the pinhole. (Note that at t=0, $1-h_{min}$ = α). Clearly, the linear theory fails to correctly predict the growth rate after $t\approx 10^7$ (6 s). [Computing with the "small-slope" Eq. (14) instead of Eq. (8) gives the same curve in Fig. 4(a), but the maximum slope of the pinhole wall at the rupture time is three times larger in the case of Eq. (14).]

Figure 5 shows the evolution of the surface shape for r=1. The transient shape approaches the equilibrium shape, which is different from the unstable trivial equilibrium h=1, and reaches this new equilibrium at $t\approx 2\times 10^4$, i.e., in a small fraction of a second. Figure 4(b) presents the growth rate data for this case. Most importantly, however, for all values of α in (0, 0.999 99], the initial deformation of the planar surface evolves to the shown equilibrium shape. Thus, the model predicts the absence of dewetting in this case.

B. Strong anisotropy

Linearization of Eq. (14) about the equilibrium solution h=1 gives

$$\xi_t = B(q\Lambda_1 \xi_{xxxx} + \Delta \xi_{xxxxxx} + W_0 \xi_{xx}), \quad \Lambda_1 \ge 0, \quad W_0 < 0.$$
(22)

The corresponding growth rate

$$\omega(k) = B(q\Lambda_1 k^4 - \Delta k^6 - W_0 k^2). \tag{23}$$

The equilibrium surface is unstable $[\omega(k)>0]$ to perturbations with the wave numbers $0< k < k_c$, and $k_c^2 = q\Lambda_1/2\Delta + (q^2\Lambda_1^2/4\Delta^2 - W_0/\Delta)^{1/2}$. For $k \ge k_c$, the equilibrium surface is stable. The maximum growth rate and the corresponding wave number can be easily obtained.

1. $\epsilon_{\gamma} = 0.0697$

For this value of ϵ_{γ} (which is larger than the critical value 1/15 by only 4.5%) and r=0.1 or r=1, the evolution of the pinhole shape is qualitatively similar to the previous case

 ϵ_{γ} =1/18 and r=1. For both values of r, the equilibrium and the transient shapes are smooth.

For r=0.1, the equilibrium shape has the minimum at z=0.92. This equilibrium state attracts all perturbations with the initial amplitudes α in (0, 0.995). For α =0.995 or larger, the pinhole tip approaches the substrate until it touches it, i.e., the pinhole dewets. By comparing this case to Fig. 3, one can see that the tiny supercritical anisotropy is almost successful in the suppression of dewetting.

For r=1, the equilibrium shape has a minimum at z=0.95, and even for $\alpha=0.999$ 99, there is no dewetting.

2.
$$\epsilon_{\nu} = 1/12$$

For r=0.1, there emerges a smooth equilibrium shape with the minimum at z=0.97, which attracts the initial perturbations with the amplitudes α in (0, 0.5]. The transient shape exhibits smooth curved "facets" and facet junctions. These facets gradually disappear as the equilibrium shape is approached. If α is in (0.5, 0.999 99], the transient shapes are truly faceted, and each shape evolves about the initial shape, becoming more faceted with time. Thus again, for $\epsilon_{\gamma} = 1/12$ and r=0.1, there is no dewetting. Figure 6 shows the initial and final shapes for α =0.8. Note that the tip of the pinhole is not faceted. In the dimensional time, the shape changes in Fig. 6 are practically instantaneous. After the low-energy orientations (0° and 90°) have been formed, the time steps required to track the evolution become very small, and the computation is interrupted. (Of course, this is the drawback of the current model based on the evolution equation for the surface height; a better model would employ the parametric representation of the surface and will allow surface slopes of 90° and larger.³⁵ I am presently working on such a model.)

For r=1, the smooth equilibrium shape has a minimum at z=0.965. This shape has a very narrow domain of attraction; already for $\alpha=0.1$, the clear tendency of the film to dewet can be seen in Fig. 7. The computation was interrupted after the last shape in Figs. 7(a) and 7(b) was dumped, since the time steps less than 10^{-10} are needed to compute further. Such small time steps are warranted since the slope of the last shape near the tip is close to 90° and the evolution is very fast. These figures also suggest that as α increases, the tip of the pinhole elongates while the rest of the pinhole shape changes little (is "left behind"). In other words, the

dewetting dynamics is confined to the tip of the pinhole. Thus, unless the facets form on the transient shape [Fig. 7(a)], a very narrow slitlike dewetting front is expected to extend to the substrate rapidly. If the facets do form, then the tendency to dewet will be partially or completely suppressed.

IV. DISCUSSION

The complex scenarios of a thin solid film dewetting under the action of a two-layer wetting potential have been computed using the nonlinear continuum model. These scenarios depend on the strength of the surface energy anisotropy, the characteristic wetting length, and on the depth of the preexisting pinhole defect in the film surface.

A film with a weak surface energy anisotropy dewets easily when the wetting potential is confined to the length scales of the order of the initial film thickness. When the wetting potential extends beyond the initial film thickness, there is no dewetting but instead the equilibrium emerges, where the pinhole is elongated but its tip does not touch the substrate.

When the anisotropy is strong, it is generally expected that the faceting prevails over dewetting. For a very strong anisotropy, either a smooth equilibrium emerges for shallow initial depths or the transient shape becomes faceted and the dewetting ceases. Equations (12) and (13) make clear the reason for such a behavior. Indeed, the dominant terms in $P_w^{(1)}$ ($P_w^{(2)}$) are proportional to h_x^{-1} (h_x^{-7}). Thus, for large slopes, the "wetting" terms are small and they lose in the competition with the anisotropic terms $P_\kappa^{(1)}$ and $P_\kappa^{(2)}$.

Two caveats must be noted. First, the averaging employed for the calculation of μ_{κ} is the approximation designed in order to obtain the simple model. Without averaging, the expression for the surface stiffness contains the exponential terms. As a result, the expressions for $P_{\kappa}^{(1)}$ and, especially, $P_{\kappa}^{(2)}$ in Eq. (8) are cumbersome and even the linear stability analysis for the strong anisotropy is complicated. In the Appendix, the partial proof is presented where the use of averaging does not qualitatively change the results and that even a quantitative impact on the dynamics due to averaging is very small. Second, this model disregards the wetting stress. However, as this reference suggests, the impact of such stress is not strong (except near the rupture point, where the stress singularity is expected).

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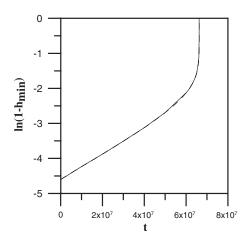


FIG. 8. Comparison of the dewetting rates for ϵ_{γ} =1/18 and r=0.1. Solid line, basic SSA model with averaging, given by Eqs. (14)–(18); dashed line, extended SSA model as described in Appendix.

APPENDIX

Here, Eqs. (3)–(5) are used as shown to derive the primary wetting part of μ_{κ} in the small-slope approximation. The contribution of wetting energy to the regularization term, $P_{\kappa}^{(2)}$, in Eq. (16), is ignored. Thus, in this extended SSA model Eqs. (16)–(18) are unchanged, but $P_{\kappa}^{(1)}$ shown in Eq. (15) is augmented by the exponential term

$$P_{\kappa,w}^{(1)} = \exp(-h/r)\{-(\Lambda_1 + \Gamma)h_{xxx} + [r^{-1}(\Lambda_1 + \Gamma) - \Lambda_2 h_{xx} + 3\Gamma h_{xx}]h_{xx}h_x + (2\Gamma - \Lambda_3)h_{xxx}h_x^2 + r^{-1}(\Lambda_3 - 2\Gamma)h_{xx}h_x^3\}.$$
(A1)

Also, since averaging is not employed, q is set equal to 1 in Eq. (14).

For the basic and the exdended models, Fig. 8 compares the dewetting rates in the case ϵ_{γ} =1/18 and r=0.1. This case was chosen because it is dominated by wetting contributions. The former rate is also shown in Fig. 4(a). Clearly, the results are identical. For the large slope cases such as shown in Figs. 6 and 7, the differences are expected to be very small, if any, since the wetting correction to $P_{\kappa}^{(1)}$ in Eq. (10) is proportional to h_x^{-3} [vs the h_x^{-1} dependence in Eq. (12)].

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